

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Haruo SHINDO ET AL.

SERIAL NO: 09/935,585

GAU:

2829 TECHNOLOGY CENTER 2800

FILED: AUGUST 24, 2001

EXAMINER: PATEL, P.

METHOD OF MEASURING ELECTRON ENERGY DISTRIBUTION IN PLASMA REGION AND
APPARATUS FOR MEASURING THE SAME

REQUEST FOR EXTENSION OF TIME
UNDER 37 C.F.R. 1.136

12/Epten
Juno
(1 MW)
J Maier
7-22-03



COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

It is hereby requested that a **one** month extension of time be granted to JULY 13, 2003 for

- ☒ filing a response to the Official Action dated: MARCH 13, 2003
- ☐ responding to the requirements in the Notice of Allowability dated:
- ☐ filing the Formal Drawings. The Issue Fee due has been timely filed.
- ☐ responding to the Notice to File Missing Parts of Application dated:
- ☐ filing a Notice of Appeal. A timely response to the final rejection, due has been filed.
- ☐ filing an Appeal Brief. A Notice of Appeal was filed on:
- ☐ Applicant claims small entity status. See 37 CFR 1.27. Therefore, the fee amount shown below is reduced by one-half.

The required fee of \$110.00 is enclosed herewith by check and any further charges may be made against the Attorney of Record's Deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.

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110.00 OP

Respectfully Submitted,

OBLON, SPIVAK, McCLELLAND,
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